IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): ITO et al.

Atty. Dkt.: 01-543

Serial No.: Unknown

Group Art Unit:

Filed: Concurrently herewith

Examiner:

Title: SEMICONDUCTOR INTEGRATED

CIRCUIT DEVICE HAVING A

SAMPLING SIGNAL GENERATION

CIRCUIT

Date: January 21, 2004

Commissioner for Patents Arlington, VA 22202

INFORMATION DISCLOSURE STATEMENT

Sir:

Pursuant to 37 C.F.R. §1.56, the reference(s) listed on the attached Form PTO-1449 is/are submitted for consideration by the Examiner without any admission that it/they constitute(s) statutory prior art, or without any admission that it/they contain(s) subject matter that anticipates the invention or renders the invention obvious to a person of ordinary skill in the art.

The Examiner is requested to initial the attached PTO Form-1449 and to return a copy of same to the undersigned attorney as proof that the listed reference(s) has/have been considered and made of record.

Respectfully submitted,

David G. Posz

Reg. No. 37,701

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* PATENT APPLICATION

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FORM PTO-1449	ATTY. DKT NO.	01-543	SER. NO.		
	APPLICANT	ITO et al.			
	FILING DATE	January 21, 2004	GROUP		

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS SUB CLASS	
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FOREIGN PATENT DOCUMENTS

TRANSLATION

TRANSLATION							
DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO
JP-A-H09-153802* (Discussed in pages 1-2 of the spec.)	06/10/97	JAPAN				X (Abstract)	
				,			
	JP-A-H09-153802* (Discussed in pages 1-2 of the	JP-A-H09-153802* (Discussed in pages 1-2 of the 06/10/97	JP-A-H09-153802* (Discussed in pages 1-2 of the 06/10/97 JAPAN	JP-A-H09-153802* (Discussed in pages 1-2 of the 06/10/97 JAPAN	JP-A-H09-153802* (Discussed in pages 1-2 of the 06/10/97 JAPAN	JP-A-H09-153802* (Discussed in pages 1-2 of the O6/10/97 JAPAN	DOCUMENT NUMBER DATE COUNTRY NAME CLASS SUB CLASS YES JP-A-H09-153802* (Discussed in pages 1-2 of the Class of th

* Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX.

EXAMINER		DATE CONSIDERED	

Rev. 10/94 (Form 3.05)